

FCC Test Report FCC ID: 055181823

Product:	2G flip phone
Trade Mark:	LOGIC, ISWAG, UNONU
Model Number:	LOGIC F11
Family Model:	Folder, U28
Report No.:	STR230328003003E

Prepared for

SWAGTEK

10205 NW 19th Street STE101 Miami, FL 33172, United States

Prepared by

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TEST RESULT CERTIFICATION

Applicant's name:	SWAGTEK
Address:	10205 NW 19th Street STE101 Miami, FL 33172, United States
Manufacturer's Name:	SWAGTEK
Address:	10205 NW 19th Street STE101 Miami, FL 33172, United States
Product description	
Product name:	2G flip phone
Model and/or type reference :	LOGIC F11
Family Model:	Folder, U28
Test Sample Number:	T230328002R003
Standards	FCC Part15B ANSI C63.4:2014

This device described above has been tested by NTEK, and the test results show that the equipment under test (EUT) is in compliance with Part 15 of FCC Rules. And it is applicable only to the tested sample identified in the report.

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Date of Test	
Date (s) of performance of tests::	Mar 28, 2023 ~ May 06, 2023
Date of Issue:	May 06, 2023
Test Result	Pass

Testing Engineer

krang. Hu

(Mary Hu)

Authorized Signatory :

Alex

(Alex Li)



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1. TEST SUMMARY

Test procedures according to the technical standards:

EMC Emission				
Standard	Test Item	Limit	Judgment	Remark
FCC Part15B ANSI C63.4: 2014	Conducted Emission	Class B	PASS	
	Radiated Emission	Class B	PASS	

NOTE:

(1) 'N/A' denotes test is not applicable in this Test Report

(2) For client's request and manual description, the test will not be executed.



1.1 TEST FACILITY

Shenzhen NTEK Testing Technology Co., LtdAdd. : 1/F, Building E, Fenda Science Park, Sanwei Community, Xixiang Street, Bao'an District,
Shenzhen 518126 P.R. China.IC-RegistrationThe Certificate Registration Number is 9270A.
CAB identifier:CN0074

FCC- Accredited Test Firm Registration Number: 463705. Designation Number: CN1184

1.2 MEASUREMENT UNCERTAINTY

The reported uncertainty of measurement $y \pm U$, where expended uncertainty U is based on a standard uncertainty multiplied by a coverage factor of k=2, providing a level of confidence of approximately 95 %.

A. Conducted Measurement :

Test Site	Method	Measurement Frequency Range	U, (dB)	NOTE
NTEKC01	ANSI	150 KHz ~ 30MHz	±2.80dB	

B. Radiated Measurement :

Test Site	Method	Measurement Frequency Range	U, (dB)	NOTE
NTEKA01	ANSI	30MHz~1000MHz	±2.64dB	
		1GHz~6GHz	±2.40dB	
		6GHz~26.5GHz	±2.52dB	



2. GENERAL INFORMATION

2.1 GENERAL DESCRIPTION OF EUT

Equipment	2G flip phone			
Trade Mark	LOGIC, ISWAG, UNONU			
Model Name	LOGIC F11	-		
Family Model	Folder, U28			
Model Difference	All the model are the same circuit and RF module, except the Model names.			
	Connecting I/O port:	Micro USB, Earphone		
Product	Operation Frequency:	2.4GHz		
Description	Based on the application, features, or specification exhibited in User's Manual, the EUT is considered as an ITE/Computing Device. More details of EUT technical specification, please refer to the User's Manual.			
Adapter	Model: WTLF-B18 Input: AC 100-240V, 50-60Hz 0.3A Output: DC 5.0V500mA			
Battery	DC 3.7V, 800mAh			
Power supply	DC 3.7V from battery or DC 5V from Adapter.			
Hardware version	M28_MB_V3.0			
Software version	LOGIC_F11_TIGO_GT	LOGIC_F11_TIGO_GT		

NTEK JLi 2.1.1 DESCRIPTION OF TEST MODES

To investigate the maximum EMI emission characteristics generates from EUT, the test system was pre-scanning tested base on the consideration of following EUT operation mode or test configuration mode which possible have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

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Pretest Mode	Description
Model 1	USB Data Transmission
Model 2	TF card Playing
Model 3	REC
Model 4	FM
Model 5	GPS

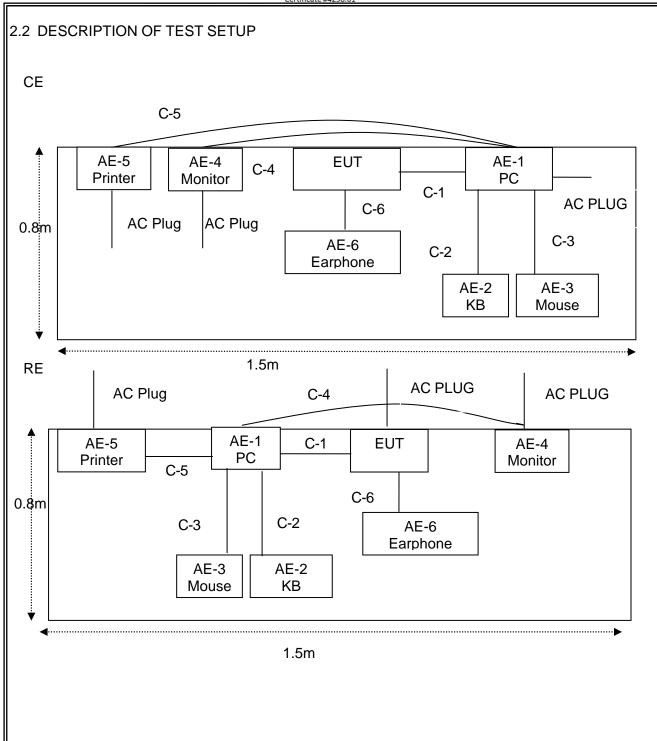
For Conducted Test			
Final Test Mode Description			
Model 1	USB Data Transmission		
Model 2	TF card Playing		
Model 3	REC		
Model 4	FM		

For Radiated Test			
Final Test Mode	Description		
Model 1	USB Data Transmission		
Model 2	TF card Playing		
Model 3	REC		
Model 4	FM		

Note: Final Test Mode: Through Pre-scan, find the model 1 is the worst case. Only the worst case mode is recorded in the report.

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2.3 DESCRIPTION TEST PERIPHERAL AND EUT PERIPHERAL

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Item	Equipment	Brand	Model/Type No.	Series No.	Note
AE-1	PC	DELL	FT4Y23X	N/A	Peripherals
AE-2	KB	N/A	N/A	N/A	Peripherals
AE-3	Mouse	DELL	MS111-P	N/A	Peripherals
AE-4	Monitor	DELL	IN2020MB	N/A	Peripherals
AE-5	Printer	Canon	L11121E	N/A	Peripherals
AE-6	Earphone	N/A	N/A	N/A	Peripherals

Item	Cable Type	Shielded Type	Ferrite Core	Length	Note
C-1	USB Cable	NO	NO	0.9m	
C-2	USB Cable	NO	NO	1.2m	
C-3	USB Cable	NO	NO	1.2m	
C-4	HDMI Cable	YES	YES	1.0m	
C-5	USB Cable	NO	NO	1.2m	
C-6	Earphone Cable	NO	NO	1.5m	

Note:

- (1) The support equipment was authorized by Declaration of Confirmation.
- (2) For detachable type I/O cable should be specified the length in cm in $\[\]$ Length $\[\]$ column.
- (3) "YES" means "shielded" "with core"; "NO" means "unshielded" "without core".

2.4 MEASUREMENT INSTRUMENTS LIST

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Radiation Test equipment							
ltem		Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibratio n period
1	Spectrum Analyzer	Aglient	E4440A	MY4100013 0	2023.03.27	2024.03.26	1 year
2	Test Receiver	R&S	ESPI	101318	2023.03.27	2024.03.26	1 year
3	Bilog Antenna	TESEQ	CBL6111D	31216	2023.03.16	2024.03.15	1 year
4	50Ω Coaxial Switch	Anritsu	MP59B	620026441 6	2020.05.11	2023.05.10	3 year
5	Spectrum Analyzer	ADVANTEST		150900201	2023.03.27	2024.03.26	1 year
6	Horn Antenna	SCHWARZB ECK	BBHA 9120 D	2816	2023.01.12	2024.01.11	1 year
7	Horn Ant	Schwarzbeck	BBHA 9170	9170-181	2022.11.07	2023.11.06	1 year
8	Amplifier	EMC	EMC05183 5SE	980246	2022.06.17	2023.06.16	1 year
9	Loop Antenna	ARA	PLA-1030/B	1029	2022.11.04	2023.11.03	1 year
10	Power Meter	DARE	RPR3006W	15I00041S NO84	2022.06.16	2023.06.15	1 year
11	Power Sensor	R&S	URV4-Z4	0395.1619. 05	2022.06.16	2023.06.15	1 year
12	Test Cable (30MHz-1GH z)	N/A	R-02	N/A	2022.06.17	2025.06.16	3 year
13	High Test Cable(1G-40 GHz)	N/A	R-03	N/A	2022.06.17	2025.06.16	3 year
14	High Test Cable(1G-40 GHz)	N/A	R-04	N/A	2022.06.17	2025.06.16	3 year
15	Test Receiver	R&S	ESCI	101160	2023.03.27	2024.03.26	1 year
<u>^ </u>	Conduction Test	toquinment					
Item		Manufactu	Type No.	Serial No.	Last calibration	Calibrated until	Calibratio n period
1	Test Receive	er R&S	ESCI	101160	2023.03.27	2024.03.26	1 year
2	LISN	R&S	ENV216	101313	2023.03.27	2024.03.26	1 year
3	LISN	SCHWAR ZBECK	NNLK 8129	8129245	2023.03.27	2024.03.26	1 year
4	50Ω Coaxial Switch	I ANRITSU CORP	MP59B	620098370 4	2020.05.11	2023.05.10	3 year
5	Test Cable (9KHz-30MHz	/	C01	N/A	2020.05.11	2023.05.10	3 year
6	Test Cable (9KHz-30MH	z) N/A	C02	N/A	2020.05.11	2023.05.10	3 year
7	Test Cable (9KHz-30MHz	NI/Δ	C03	N/A	2020.05.11	2023.05.10 e Test Cable w	3 year

Note: Each piece of equipment is scheduled for calibration once a year except the Test Cable which is scheduled for calibration every 3 years.



3. EMC EMISSION TEST

3.1 CONDUCTED EMISSION MEASUREMENT

3.1.1 POWER LINE CONDUCTED EMISSION (Frequency Range 150KHz-30MHz)

FREQUENCY (MHz)	Class A	(dBuV)	Class B (dBuV)		
	Quasi-peak	Average	Quasi-peak	Average	
0.15 -0.5	79.00	66.00	66 - 56 *	56 - 46 *	
0.50 -5.0	73.00	60.00	56.00	46.00	
5.0 -30.0	73.00	60.00	60.00	50.00	

Note:

(1) The tighter limit applies at the band edges.

(2) The limit of " * " marked band means the limitation decreases linearly with the logarithm of the frequency in the range.

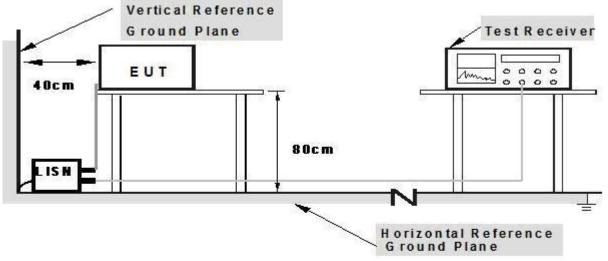
The following table is the setting of the receiver

Receiver Parameters	Setting	
Attenuation	10 dB	
Start Frequency	0.15 MHz	
Stop Frequency	30 MHz	
IF Bandwidth	9 kHz	

3.1.2 TEST PROCEDURE

- a. The EUT was placed 0.8 meters from the horizontal ground plane with EUT being connected to the power mains through a line impedance stabilization network (LISN). All other support equipments powered from additional LISN(s). The LISN provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- b. Interconnecting cables that hang closer than 40 cm to the ground plane shall be folded back and forth in the center forming a bundle 30 to 40 cm long.
- c. I/O cables that are not connected to a peripheral shall be bundled in the center. The end of the cable may be terminated, if required, using the correct terminating impedance. The overall length shall not exceed 1 m.
- d. LISN at least 80 cm from nearest part of EUT chassis.
- e. For the actual test configuration, please refer to the related Item -EUT Test Photos.

3.1.3 TEST SETUP



Note: 1.Support units were connected to second LISN. 2.Both of LISNs (AMN) are 80 cm from EUT and at least 80 from other units and other metal planes

3.1.4 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of **2.3** Unless otherwise a special operating condition is specified in the follows during the testing.



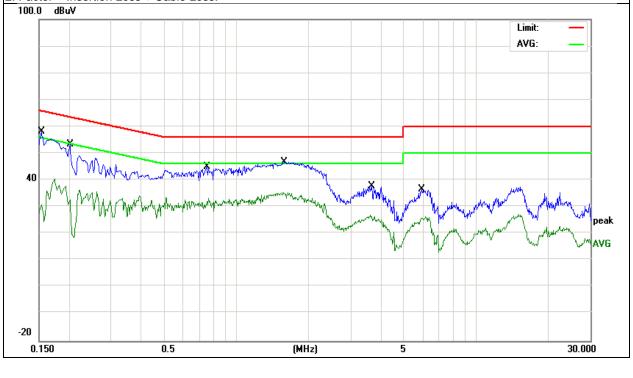
3.1.5 TEST RESULTS

EUT:	2G flip pho	ne	Mod	el Name. :	LOGIC F11	
Temperature:	Temperature: 24.5 °C		Rela	tive Humidity:	52%	
Pressure:	1010hPa		Test	Date:	2023-04-06	
Test Mode:	Mode 1		Pha	se :	L	
Test Voltage:	DC 5V from	n PC AC 120V	//60Hz			
Frequency	Reading Level	Correct Factor	Measure-mer t	Limits	Margin	Remark
(MHz)	(dBµV)	(dB)	(dBµV)	(dBµV)	(dB)	Roman
0.1539	48.51	9.60	58.11	65.78	-7.67	QP
0.1539	21.11	9.60	30.71	55.78	-25.07	AVG
0.2020	43.87	9.62	53.49	63.52	-10.03	QP
0.2020	20.11	9.62	29.73	53.52	-23.79	AVG
0.7539	35.36	9.68	45.04	56.00	-10.96	QP
0.7539	22.23	9.68	31.91	46.00	-14.09	AVG
1.5859	37.09	9.67	46.76	56.00	-9.24	QP
1.5859	25.42	9.67	35.09	46.00	-10.91	AVG
3.6660	28.02	9.74	37.76	56.00	-18.24	QP
3.6660	16.64	9.74	26.38	46.00	-19.62	AVG
5.9060	26.74	9.81	36.55	60.00	-23.45	QP
5.9060	15.85	9.81	25.66	50.00	-24.34	AVG

Remark:

1. All readings are Quasi-Peak and Average values.

2. Factor = Insertion Loss + Cable Loss.



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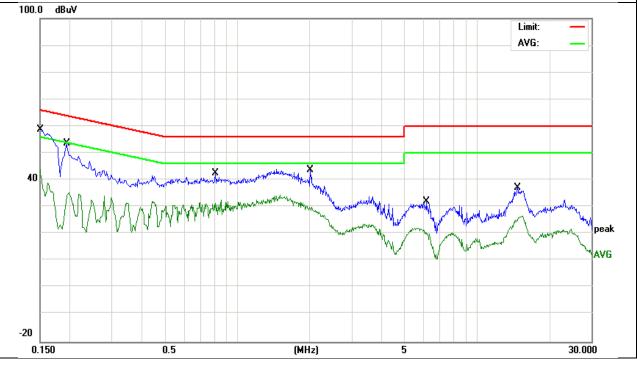
EUT: 2G flip phone Model Name. : LOGIC F11	
Temperature:24.5 °CRelative Humidity:52%	
Pressure: 1010hPa Test Date: 2023-04-06	
Test Mode: Mode 1 Phase : N	
Test Voltage: DC 5V from PC AC 120V/60Hz	

Frequency	Reading Level	Correct Factor	Measure-ment	Limits	Margin	- -
(MHz)	(dBµV)	(dB)	(dBµV)	(dBµV)	(dB)	Remark
0.1500	49.20	9.65	58.85	65.99	-7.14	QP
0.1500	34.28	9.65	43.93	55.99	-12.06	AVG
0.1940	44.02	9.63	53.65	63.86	-10.21	QP
0.1940	24.84	9.63	34.47	53.86	-19.39	AVG
0.8100	33.01	9.68	42.69	56.00	-13.31	QP
0.8100	21.68	9.68	31.36	46.00	-14.64	AVG
2.0020	34.02	9.67	43.69	56.00	-12.31	QP
2.0020	20.39	9.67	30.06	46.00	-15.94	AVG
6.1620	22.34	9.79	32.13	60.00	-27.87	QP
6.1620	10.54	9.79	20.33	50.00	-29.67	AVG
14.8140	27.03	10.04	37.07	60.00	-22.93	QP
14.8140	15.05	10.04	25.09	50.00	-24.91	AVG

Remark:

1. All readings are Quasi-Peak and Average values.

2. Factor = Insertion Loss + Cable Loss.





3.2 RADIATED EMISSION MEASUREMENT

3.2.1 LIMITS OF RADIATED EMISSION MEASUREMENT

	Class A (at 10m)	Class B (at 3m)	
FREQUENCY (MHz)	dBuV/m	dBuV/m	
30 ~ 88	39.0	40.0	
88 ~ 216	43.5	43.5	
216 ~ 960	46.5	46.0	
Above 960	49.5	54.0	

Notes:

- (1) The limit for radiated test was performed according to as following: FCC PART 15B /ICES-003.
- (2) The tighter limit applies at the band edges.
- (3) Emission level (dBuV/m)=20log Emission level (uV/m).

3.2.2 TEST PROCEDURE

Test Arrangement for Radiated Emissions up to 1 GHz

- a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at an accredited test facility. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The antenna is a broadband antenna, and its height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.

Note: The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 120kHz for quasi-peak detection (QP) at frequency below 1GHz.

Test Arrangement for Radiated Emissions above 1 GHz.

a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at an accredited chamber room. The table was rotated 360 degrees to determine the position of the highest radiation.

b. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.

- c. The height of antenna can be varied from one meter to four meters, the height of adjustment depends on the EUT height and the antenna 3dB beamwidth both, to detect the maximum value of the field strength.Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.

Note: For the hand-held device, the EUT should be measured for all 3 axes and only the worst case is recorded in the report

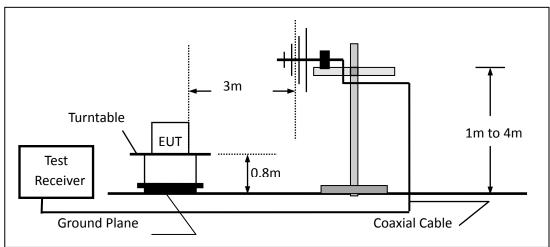


During the radiated emission test, according to ANSI C63.4-2014(4.2), the Spectrum Analyzer was set with the following configurations:

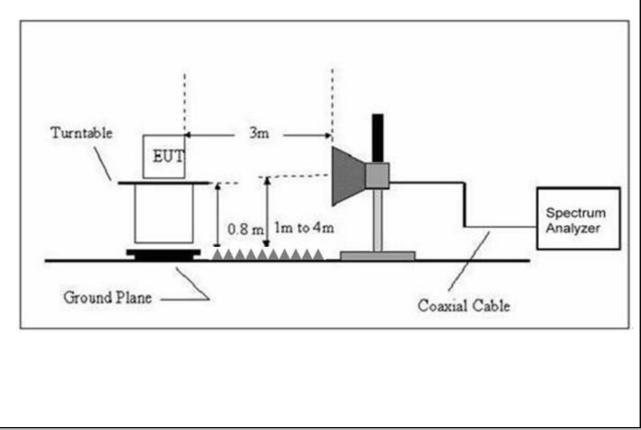
Frequency Band (MHz)	Function	Resolution bandwidth	Video Bandwidth
30 to 1000	QP	120 kHz	300 kHz
	Peak	1 MHz	3 MHz
Above 1000	Avg	1 MHz	10 Hz

3.2.3 TEST SETUP

For Radiated Emission 30~1000MHz



(B) Radiated Emission Test Set-Up Frequency Above 1GHz





3.2.4 TEST RESULTS

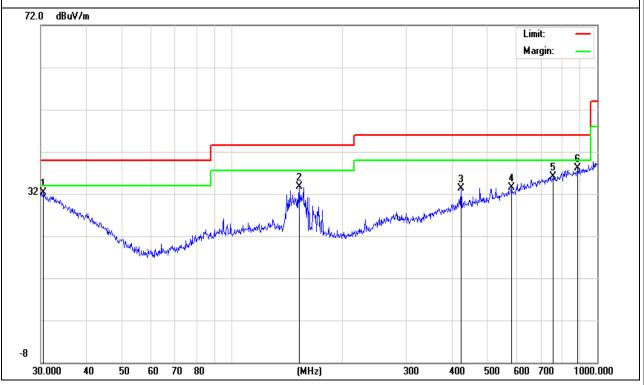
TEST RESULTS (30~1000 MHz)

EUT:	2G flip phone	Model Name:	LOGIC F11
Temperature:	24.5 ℃	Relative Humidity:	55%
Pressure:	1010 hPa	Test Date :	2023-04-04
Test Mode :	Mode 1	Polarization :	Horizontal
Test Power :	DC 5V from PC AC 120V/60Hz		

Polar	Frequency	Meter Reading	Factor	Emission Level	Limits	Margin	Remark
(H/V)	(MHz)	(dBuV)	(dB)	(dBuV/m)	(dBuV/m)	(dB)	
Н	30.5305	6.06	26.17	32.23	40.00	-7.77	QP
Н	153.2004	15.21	18.41	33.62	43.50	-9.88	QP
Н	423.5403	9.68	23.72	33.40	46.00	-12.60	QP
Н	582.7425	7.32	26.22	33.54	46.00	-12.46	QP
Н	758.0407	7.18	28.96	36.14	46.00	-9.86	QP
Н	881.4067	7.54	30.57	38.11	46.00	-7.89	QP

Remark:

Factor = Antenna Factor + Cable Loss - Amplifier.



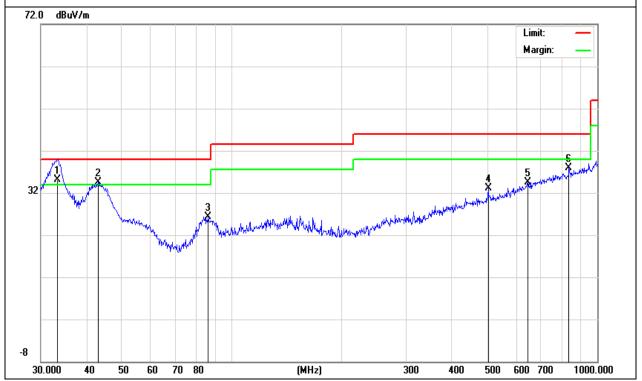


EUT:	2G flip phone	Model Name :	LOGIC F11
Temperature:	24.5 ℃	Relative Humidity:	55%
Pressure:	1010 hPa	Test Date :	2023-04-04
Test Mode :	Mode 1	Polarization :	Vertical
Test Power :	DC 5V from PC AC 120V/60Hz		

Polar (H/V)	Frequency	Meter Reading	Factor	Emission Level	Limits	Margin	Remark
	(MHz)	(dBuV)	(dB)	(dBuV/m)	(dBuV/m)	(dB)	rtemart
V	33.2288	10.48	24.68	35.16	40.00	-4.84	QP
V	43.0505	15.17	19.27	34.44	40.00	-5.56	QP
V	86.2001	10.11	16.23	26.34	40.00	-13.66	QP
V	502.9395	8.18	24.90	33.08	46.00	-12.92	QP
V	645.1195	7.41	27.12	34.53	46.00	-11.47	QP
V	836.2441	7.81	30.05	37.86	46.00	-8.14	QP

Remark:

Factor = Antenna Factor + Cable Loss - Amplifier.



3.2.5 TEST RESULTS(1000~18000MHz)

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EUT:	2G flip phone	Model Name :	LOGIC F11			
Temperature:	24.5 ℃	Relative Humidity:	55%			
Pressure:	1010 hPa	Test Date :	2023-04-04			
Test Mode :	Mode 1					
Test Power :	Power : DC 5V from PC AC 120V/60Hz					
All the medulation medea have been tested, and the worst result was report as helowy						

All the modulation modes have been tested, and the worst result was report as below:

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Polar (H/V)	Frequency	Reading	Correct	Result	Limit	Over Limit	Remark	
	(MHz)	(dBuV/m)	dB/m	(dBuV/m)	(dBuV/m)	(dB)		
V	12254.000	31.11	27.39	58.50	74.00	-15.50	peak	
V	12254.000	13.31	27.39	40.70	54.00	-13.30	AVG	
V	14736.000	31.43	28.47	59.90	74.00	-14.10	peak	
V	14736.000	13.24	28.47	41.71	54.00	-12.29	AVG	
V	17099.000	32.86	27.34	60.20	74.00	-13.80	peak	
V	17099.000	14.32	27.34	41.66	54.00	-12.34	AVG	
Н	13274.000	31.20	28.54	59.74	74.00	-14.26	peak	
Н	13274.000	13.29	28.54	41.83	54.00	-12.17	AVG	
Н	15161.000	32.25	27.95	60.20	74.00	-13.80	peak	
Н	15161.000	14.37	27.95	42.32	54.00	-11.68	AVG	
Н	16674.000	33.98	27.26	61.24	74.00	-12.76	peak	
Н	16674.000	15.35	27.26	42.61	54.00	-11.39	AVG	

Remark:

Result = Reading + Correct, Over Limit= Result - Limit Note: Only the worst results data points are reported in the report.

Other emissions are attenuated 20dB below the limit that does not recorded in the report.

END OF REPORT